

Application No.	Applicant(s)	
10/689,504	ODINAK ET AL.	
Examiner	Art Unit	
Yonel Beaulieu	3661	

SEARCHED				
Class	Subclass	Date	Examiner	
701	200	1/18/2005	YB	
-	202			
-	208			
	211			
340	988			
342	357.08			
<u>.                                      </u>				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
1					

SEARCH (INCLUDING SEAR		<b>(</b> )
	DATE	EXMR
WEST	1/18/2005	ΥВ
Inventor's Name Search	1/18/2005	YB